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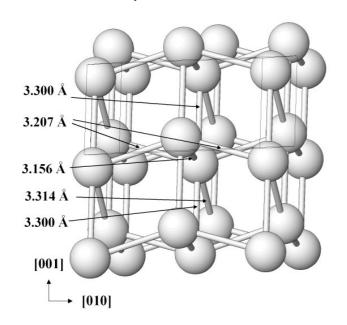
Refinement of the crystal structure of Bi-II, at 2.54 GPa

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Abstract

Bi, monoclinic, C12/m1 (No. 12), a = 6.67256(1) Å, b = 6.1108(2) Å, c = 3.30013(9) Å, $\beta = 110.412(2)^\circ$, V = 126.1 Å³, Z = 4, R(P) = 0.118, R(I) = 0.087, T = 295 K, P = 2.54 GPa.

Source of material

Bismuth of 99.999% purity (ABCR GmbH, Germany) was used for the experiments. Polycrystalline samples were obtained by grinding of bismuth granules at ambient conditions.

Experimental details

Angle-dispersive X-ray powder diffraction experiments were performed on ID-9 at ESRF using an image plate detector. The powdered particles were placed in a gasketed diamond anvil high-pressure cell using a small sphere of ruby for pressure calibration and a 4:1 mixture of ethanol and methanol as a pressure transmitting medium.

Discussion

The crystal structure of the high-pressure modification Bi-II was proposed using time-of-flight neutron diffraction data [1]. Hereby, the atomic coordinates were determined only approximately: Bi in the 4i site with x = 1/4 and z = 1/8. The need for more detailed values for the atomic parameters in the Bi-II structure was recognized in the course of our investigations on crystal structures and chemical bonding at elevated pressures [2,3]. The re-established coordinates for the unique bismuth position in the Bi-II crystal structure (cf. Table 2) differ remarkably from the previously found values [1]. This does not change the general interpretation of the structure as a strongly distorted cubic primitive packing [4]. The level of deformation with respect to the rhombohedral phase is definitely higher as supposed previously, which can be illustrated by comparison of the shortest interatomic distances: $1 \times 3.156(3)$ Å, $2 \times 3.2073(8)$ Å, $2 \times 3.300(3)$ Å and $1 \times 3.156(3)$ Å 3.314(3) Å in the present work and 1×3.145 Å, 2×3.165 Å, $2 \times$ 3.300 Å and $1 \times 3.391 \text{ Å}$ by applying the atomic coordinates from [1]. This could explain the difficulties to simulate the Bi-I to Bi-II transformation by means of the density functional calculations [5]. With the re-determined atomic parameters, the structure of Bi-II at 2.54 GPa is more distinct from the Bi-I modification, as it could be assumed before. The Bi-II structure can be derived by distortion of the Bi-I arrangement. The according interatomic distances in the Bi-I structure at 2.2 GPa are $3 \times 3.070(3)$ Å and $3 \times 3.070(3)$ 3.385(3) Å (own data).

Table 1. Data collection and handling

Powder: black, size $5-10 \,\mu m$ Wavelength: synchrotron radiation (0.41844 Å) μ : $365.4 \, cm^{-1}$ Diffractometer: MAR 3450 $2\theta_{\text{max}}$, stepwidth: 24.8° , 0.01° $N(points)_{\text{measured}}$: 2178 $N(hkl)_{\text{measured}}$: 80 $N(param)_{\text{refined}}$: 8Programs: WinCSD [6], ImageIntegrator [7]

Table 2. Atomic coordinates and displacement parameters (in \mathring{A}^2).

Atom	Site	x	у	z	U_{11}	U_{22}	U_{33}	U_{12}	U_{13}	U_{23}
Bi	4i	0.2518(3)	0	0.1490(6)	0.049(1)	0.049(1)	0.069(2)	0	0.028(1)	0

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